Search Notes

Application/Control No.	Applio Reexa

Applicant(s)/Patent under Reexamination
WELLER ET AL.

09/943,458

Examiner

Young J. Kim

Art Unit

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SEARCH NOT (INCLUDING SEARCH)
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Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy	2/10/2006	YJK
Patent Databases text-search updated	2/13/2006	YJK
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